## NPN Silicon Power Transistors 1 kV SWITCHMODE ${ }^{\text {T }}$ Series

These transistors are designed for high-voltage, high-speed, power switching in inductive circuits where fall time is critical. They are particularly suited for line-operated SWITCHMODE applications.

## MJW16010A*

*ON Semiconductor Preferred Device

POWER TRANSISTORS 15 AMPERES 500 VOLTS 125 AND 175 WATTS

Typical Applications:

- Switching Regulators
- Inverters
- Solenoids
- Relay Drivers
- Motor Controls
- Deflection Circuits


## Features:

- Collector-Emitter Voltage - $\mathrm{V}_{\mathrm{CEV}}=1000 \mathrm{Vdc}$
- Fast Turn-Off Times
- 50 ns Inductive Fall Time - $100^{\circ} \mathrm{C}$ (Typ)
- 90 ns Inductive Crossover Time - $100^{\circ} \mathrm{C}$ (Typ)
- 900 ns Inductive Storage Time - $100^{\circ} \mathrm{C}$ (Typ)
- $100^{\circ} \mathrm{C}$ Performance Specified for:

Reverse-Biased SOA with Inductive Load
Switching Times with Inductive Loads
Saturation Voltages
Leakage Currents

- Extended FBSOA Rating Using Ultra-fast Rectifiers
- Extremely High RBSOA Capability


MAXIMUM RATINGS

| Rating | Symbol | Value | Unit |
| :---: | :---: | :---: | :---: |
| Collector-Emitter Voltage | $\mathrm{V}_{\text {CEO }}$ | 500 | Vdc |
| Collector-Emitter Voltage | $\mathrm{V}_{\text {CEV }}$ | 1000 | Vdc |
| Emitter-Base Voltage | $V_{\text {Eb }}$ | 6 | Vdc |
| Collector CurrentContinuous $\qquad$ | $\begin{gathered} \mathrm{I}_{\mathrm{C}} \\ \mathrm{I}_{\mathrm{CM}} \end{gathered}$ | $\begin{aligned} & \hline 15 \\ & 20 \end{aligned}$ | Adc |
| Base Current - Continuous $\text { - Peak }{ }^{(1)}$ | $\begin{gathered} \mathrm{I}_{\mathrm{B}} \\ \mathrm{I}_{\mathrm{BM}} \end{gathered}$ | $\begin{aligned} & \hline 10 \\ & 15 \end{aligned}$ | Adc |
| Total Power Dissipation $\begin{gathered} @ \mathrm{~T}_{\mathrm{C}}=25^{\circ} \mathrm{C} \\ @ \mathrm{~T}_{\mathrm{C}}=100^{\circ} \mathrm{C} \\ \text { Derate above } \mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C} \end{gathered}$ | $\mathrm{P}_{\mathrm{D}}$ | $\begin{gathered} \hline 135 \\ 54 \\ 1.09 \end{gathered}$ | Watts <br> $\mathrm{W} /{ }^{\circ} \mathrm{C}$ |
| Operating and Storage Junction Temperature Range | $\mathrm{T}_{\mathrm{J}}, \mathrm{T}_{\text {stg }}$ | -55 to 150 | $I_{C}$ |

THERMAL CHARACTERISTICS

| Characteristic | Symbol | Max | Unit |
| :--- | :---: | :---: | :---: |
| Thermal Resistance, Junction to Case | $\mathrm{R}_{\text {өJC }}$ | 0.92 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| Lead Temperature for Soldering Purposes: <br> $1 / 8^{\prime \prime}$ from Case for 5 Seconds | $\mathrm{T}_{\mathrm{L}}$ | 275 | ${ }^{\circ} \mathrm{C}$ |

(1) Pulse Test: Pulse Width $=5 \mathrm{~ms}$, Duty Cycle $\leq 10 \%$.

ELECTRICAL CHARACTERISTICS $\left(\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}\right.$ unless otherwise noted)

| Characteristic | Symbol | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
| OFF CHARACTERISTICS ${ }^{(1)}$ |  |  |  |  |  |
| Collector-Emitter Sustaining Voltage (Table 1) $\left(\mathrm{I}_{\mathrm{C}}=100 \mathrm{~mA}, \mathrm{I}_{\mathrm{B}}=0\right)$ | $\mathrm{V}_{\text {CEO(sus) }}$ | 500 | - | - | Vdc |
| Collector Cutoff Current $\begin{aligned} & \left(\mathrm{V}_{\mathrm{CEV}}=1000 \mathrm{Vdc}, \mathrm{~V}_{\mathrm{BE}(\text { (off })}=1.5 \mathrm{Vdc}\right) \\ & \left(\mathrm{V}_{\mathrm{CEV}}=1000 \mathrm{Vdc}, \mathrm{~V}_{\mathrm{BE}(\text { (off })}=1.5 \mathrm{Vdc}, \mathrm{~T}_{\mathrm{C}}=100^{\circ} \mathrm{C}\right) \end{aligned}$ | ICEV |  | $\begin{aligned} & 0.003 \\ & 0.020 \end{aligned}$ | $\begin{gathered} 0.15 \\ 1.0 \end{gathered}$ | mAdc |
| Collector Cutoff Current $\left(\mathrm{V}_{\mathrm{CE}}=1000 \mathrm{Vdc}, \mathrm{R}_{\mathrm{BE}}=50 \Omega, \mathrm{~T}_{\mathrm{C}}=100^{\circ} \mathrm{C}\right)$ | ICER | - | 0.020 | 1.0 | mAdc |
| Emitter Cutoff Current $\left(\mathrm{V}_{\mathrm{EB}}=6 \mathrm{Vdc}, \mathrm{I}_{\mathrm{C}}=0\right)$ | $\mathrm{I}_{\text {Ebo }}$ | - | 0.005 | 0.15 | mAdc |

## SECOND BREAKDOWN

| Second Breakdown Collector Current with Base Forward Biased | $\mathrm{I}_{\mathrm{S} / \mathrm{b}}$ | See Figure 14a or 14b |
| :--- | :---: | :---: |
| Clamped Inductive SOA with Base Reverse Biased | RBSOA | See Figure 15 |

ON CHARACTERISTICS( ${ }^{1)}$

| $\begin{aligned} & \text { Collector-Emitter Saturation Voltage } \\ & \quad\left(I_{C}=5 \mathrm{Adc}, \mathrm{I}_{\mathrm{B}}=1 \mathrm{Adc}\right) \\ & \left(\mathrm{I}_{\mathrm{C}}=10 \mathrm{Adc}, \mathrm{I}_{\mathrm{B}}=2 \mathrm{Adc}\right) \\ & \left(\mathrm{I}_{\mathrm{C}}=10 \mathrm{Adc}, \mathrm{I}_{\mathrm{B}}=2 \mathrm{Adc}, \mathrm{~T}_{\mathrm{C}}=100^{\circ} \mathrm{C}\right) \end{aligned}$ | $\mathrm{V}_{\text {CE(sat) }}$ | - | $\begin{aligned} & 0.25 \\ & 0.45 \\ & 0.60 \end{aligned}$ | $\begin{gathered} 0.7 \\ 1 \\ 1.5 \end{gathered}$ | Vdc |
| :---: | :---: | :---: | :---: | :---: | :---: |
| $\begin{aligned} & \text { Base-Emitter Saturation Voltage } \\ & \quad\left(\mathrm{I}_{\mathrm{C}}=10 \mathrm{Adc}, \mathrm{I}_{\mathrm{B}}=2 \mathrm{Adc}\right) \\ & \left(\mathrm{I}_{\mathrm{C}}=10 \mathrm{Adc}, \mathrm{I}_{\mathrm{B}}=2 \mathrm{Adc}, \mathrm{~T}_{\mathrm{C}}=100^{\circ} \mathrm{C}\right) \end{aligned}$ | $\mathrm{V}_{\mathrm{BE} \text { (sat) }}$ | - | $\begin{aligned} & 1.2 \\ & 1.2 \end{aligned}$ | $\begin{aligned} & 1.5 \\ & 1.5 \end{aligned}$ | Vdc |
| DC Current Gain $\left(\mathrm{I}_{\mathrm{C}}=15 \mathrm{Adc}, \mathrm{V}_{\mathrm{CE}}=5 \mathrm{Vdc}\right)$ | $\mathrm{h}_{\text {FE }}$ | 5 | 8 | - | - |

## DYNAMIC CHARACTERISTICS

| Output Capacitance <br> $\left(\mathrm{V}_{\mathrm{CB}}=10 \mathrm{Vdc}, \mathrm{I}_{\mathrm{E}}=0, \mathrm{f}_{\text {test }}=1 \mathrm{kHz}\right)$ | $\mathrm{C}_{\mathrm{ob}}$ | - | - | 400 | pF |
| :--- | :--- | :--- | :--- | :--- | :--- |

SWITCHING CHARACTERISTICS

| Inductive Load (Table | 1) |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Storage Time | $\begin{aligned} & \left(\mathrm{I}_{\mathrm{C}}=10 \mathrm{Adc},\right. \\ & \mathrm{I}_{\mathrm{B} 1}=1.3 \mathrm{Adc}, \\ & \mathrm{~V}_{\mathrm{BE}(\mathrm{off})}=5 \mathrm{Vdc}, \\ & \left.\mathrm{~V}_{\mathrm{CE}(\mathrm{pk})}=400 \mathrm{Vdc}\right) \end{aligned}$ | $\left(T_{J}=100^{\circ} \mathrm{C}\right)$ | $\mathrm{t}_{\mathrm{sv}}$ | - | 900 | 2000 | ns |
| Fall Time |  |  | $\mathrm{t}_{\mathrm{fi}}$ | - | 50 | 250 |  |
| Crossover Time |  |  | $\mathrm{t}_{\mathrm{c}}$ | - | 90 | 300 |  |
| Storage Time |  | $\left(T_{J}=150^{\circ} \mathrm{C}\right)$ | $\mathrm{t}_{\text {sv }}$ | - | 1100 | - |  |
| Fall Time |  |  | tfil | - | 70 | - |  |
| Crossover Time |  |  | $\mathrm{t}_{\mathrm{c}}$ | - | 120 | - |  |
| Resistive Load (Table 2) |  |  |  |  |  |  |  |
| Delay Time | $\begin{aligned} & \left(\mathrm{I}_{\mathrm{C}}=10 \mathrm{Adc},\right. \\ & \mathrm{V}_{\mathrm{CC}}=250 \mathrm{Vdc}, \\ & \mathrm{I}_{\mathrm{B} 1}=1.3 \mathrm{Adc}, \\ & \mathrm{PW}=30 \mu \mathrm{~s}, \\ & \text { Duty Cycle } \leq 2 \%) \end{aligned}$ | $\begin{aligned} & \left(\mathrm{l}_{\mathrm{B} 2}=2.6 \mathrm{Adc},\right. \\ & \left.\mathrm{R}_{\mathrm{B} 2}=1.6 \Omega\right) \end{aligned}$ | $t_{d}$ | - | 25 | 100 | ns |
| Rise Time |  |  | $\mathrm{tr}_{\mathrm{r}}$ | - | 325 | 600 |  |
| Storage Time |  |  | $\mathrm{t}_{\text {s }}$ | - | 1300 | 3000 |  |
| Fall Time |  |  | $t_{f}$ | - | 175 | 400 |  |
| Storage Time |  | $\left(\mathrm{V}_{\mathrm{BE} \text { (off) }}=5 \mathrm{Vdc}\right)$ | $\mathrm{t}_{\text {s }}$ | - | 700 | - |  |
| Fall Time |  |  | $\mathrm{t}_{\mathrm{f}}$ | - | 80 | - |  |

(1) Pulse Test: PW $=300 \mu \mathrm{~s}$, Duty Cycle $\leq 2 \%$.

TYPICAL STATIC CHARACTERISTICS


Figure 1. DC Current Gain


Figure 3. Collector-Emitter Saturation Region


Figure 2. Collector-Emitter Saturation Region


Figure 4. Base-Emitter Saturation Region


Figure 5. Capacitance

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## TYPICAL INDUCTIVE SWITCHING CHARACTERISTICS

$$
\mathrm{I}_{\mathrm{C}} / \mathrm{I}_{\mathrm{B} 1}=5, \mathrm{~T}_{\mathrm{C}}=75^{\circ} \mathrm{C}, \mathrm{~V}_{\mathrm{CE}(\mathrm{pk})}=400 \mathrm{~V}
$$



Figure 6. Storage Time


Figure 8. Collector Current Fall Time

$\mathrm{I}_{\mathrm{C}} / \mathrm{I}_{\mathrm{B} 1}=10, \mathrm{~T}_{\mathrm{C}}=75^{\circ} \mathrm{C}, \mathrm{V}_{\mathrm{CE}(\mathrm{pk})}=400 \mathrm{~V}$


Figure 7. Storage Time


Figure 9. Collector Current Fall Time


## MJW16010A

Table 1. Inductive Load Switching



Figure 13. Peak Reverse Base Current

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Table 2. Resistive Load Switching

*Tektronix AM503 P6302 or Equivalent



Figure 14. Maximum Rated Forward Biased Safe Operating Area


Figure 15. Maximum Reverse Biased Safe Operating Area


Figure 16. Power Derating

## MJW16010A



Figure 17. Switching Safe Operating Area


Figure 18. Thermal Response

## SAFE OPERATING AREA INFORMATION

## FORWARD BIAS

There are two limitations on the power handling ability of a transistor: average junction temperature and second breakdown. Safe operating area curves indicate $I_{C}-V_{C E}$ limits of the transistor that must be observed for reliable operation; i.e., the transistor must not be subjected to greater dissipation than the curves indicate.

The data of Figures 14 a and 14 b is based on $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$; $\mathrm{T}_{\mathrm{J}(\mathrm{pk})}$ is variable depending on power level. Second breakdown pulse limits are valid for duty cycles to $10 \%$ but must be derated when $\mathrm{T}_{\mathrm{C}} \geq 25^{\circ} \mathrm{C}$. Second breakdown limitations do not derate the same as thermal limitations. Allowable current at the voltages shown on Figures 14a and 14b may be found at any case temperature by using the appropriate curve on Figure 16.
$\mathrm{T}_{\mathrm{J}(\mathrm{pk})}$ may be calculated from the data in Figure 18. At high case temperatures, thermal limitations will reduce the power that can be handled to values less than the limitations imposed by second breakdown.

## REVERSE BIAS

For inductive loads, high voltage and high current must be sustained simultaneously during turn-off, in most cases, with the base-to-emitter junction reverse biased. Under these conditions the collector voltage must be held to a safe level at or below a specific value of collector current. This can be accomplished by several means such as active clamping, RC snubbing, load line shaping, etc. The safe level for these devices is specified as Reverse Biased Safe Operating Area and represents the voltage-current condition allowable during reverse biased turn-off. This rating is verified under clamped conditions so that the device is never subjected to an avalanche mode. Figure 15 gives the RBSOA characteristics.

## SWITCHMODE DESIGN CONSIDERATIONS

## 1. FBSOA -

Allowable dc power dissipation in bipolar power transistors decreases dramatically with increasing collector-emitter voltage. A transistor which safely dissipates 100 watts at 10 volts will typically dissipate less than 10 watts at its rated $\mathrm{V}_{\mathrm{CEO}(\mathrm{sus})}$. From a power handling point of view, current and voltage are not interchangeable (see Application Note AN875).

## 2. TURN-ON -

Safe turn-on load line excursions are bounded by pulsed FBSOA curves. The $10 \mu$ s curve applies for resistive loads, most capacitive loads, and inductive loads that are clamped by standard or fast recovery rectifiers. Similarly, the 100 ns
curve applies to inductive loads which are clamped by ultra-fast recovery rectifiers, and are valid for turn-on crossover times less than 100 ns (see Application Note AN952).

At voltages above $75 \%$ of $\mathrm{V}_{\mathrm{CEO}(\mathrm{sus})}$, it is essential to provide the transistor with an adequate amount of base drive VERY RAPIDLY at turn-on. More specifically, safe operation according to the curves is dependent upon base current rise time being less than collector current rise time. As a general rule, a base drive compliance voltage in excess of 10 volts is required to meet this condition (see Application Note AN875).

## 3. TURN-OFF -

A bipolar transistor's ability to withstand turn-off stress is dependent upon its forward base drive. Gross overdrive violates the RBSOA curve and risks transistor failure. For this reason, circuits which use fixed base drive are often more likely to fail at light loads due to heavy overdrive (see Application Note AN875).

## 4. OPERATION ABOVE $\mathrm{V}_{\text {CEO(sus) }}$ -

When bipolars are operated above collector-emitter breakdown, base drive is crucial. A rapid application of adequate forward base current is needed for safe turn-on, as is a stiff negative bias needed for safe turn-off. Any hiccup in the base-drive circuitry that even momentarily violates either of these conditions will likely cause the transistor to fail. Therefore, it is important to design the driver so that its output is negative in the absence of anything but a clean crisp input signal (see Application Note AN952).

## 5. RBSOA -

Reverse Biased Safe Operating Area has a first order dependency on circuit configuration and drive parameters. The RBSOA curves in this data sheet are valid only for the conditions specified. For a comparison of RBSOA results in several types of circuits (see Application Note AN951).

## 6. DESIGN SAMPLES -

Transistor parameters tend to vary much more from wafer lot to wafer lot, over long periods of time, than from one device to the next in the same wafer lot. For design evaluation it is advisable to use transistors from several different date codes.

## 7. BAKER CLAMPS -

Many unanticipated pitfalls can be avoided by using Baker Clamps. MUR105 and MUR1100 diodes are recommended for base drives less than 1 amp . Similarly, MUR405 and MUR4100 types are well-suited for higher drive requirements (see Article Reprint AR131).

## PACKAGE DIMENSIONS

TO-247
CASE 340K-01
ISSUE C


NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: MILLIMETER.

| DIM | MILLIMETERS |  | INCHES |  |
| :---: | :---: | :---: | :---: | :---: |
|  | MIN | MAX | MIN | MAX |
| A | 19.7 | 20.3 | 0.776 | 0.799 |
| B | 15.3 | 15.9 | 0.602 | 0.626 |
| C | 4.7 | 5.3 | 0.185 | 0.209 |
| D | 1.0 | 1.4 | 0.039 | 0.055 |
| E | 1.27 REF |  | 0.050 REF |  |
| F | 2.0 | 2.4 | 0.079 | 0.094 |
| G | 5.5 BSC |  | 0.216 BSC |  |
| H | 2.2 | 2.6 | 0.087 | 0.102 |
| J | 0.4 | 0.8 | 0.016 | 0.031 |
| K | 14.2 | 14.8 | 0.559 | 0.583 |
| L | 5.5 NOM |  | 0.217 NOM |  |
| P | 3.7 | 4.3 | 0.146 | 0.169 |
| Q | 3.55 | 3.65 | 0.140 | 0.144 |
| R | 5.0 NOM |  | 0.197 NOM |  |
| U | 5.5 BSC |  | 0.217 BSC |  |
| V | 3.0 | 3.4 | 0.118 | 0.134 |

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#### Abstract

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